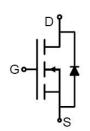


Feature

• 30V,40A

$$\begin{split} &R_{DS\ (ON)} < 9m\,\Omega\,@V_{GS} = 10V & TYP = 6.5\,m\,\Omega \\ &R_{DS\ (ON)} < 14m\,\Omega\,@V_{GS} = 4.5V & TYP = 9.0\,m\,\Omega \end{split}$$

- Advanced Trench Technology
- Lead free product is acquired
- Excellent R DS (ON) and Low Gate Charge



Schematic Diagram

Application

- PWM applications
- Load Switch
- Power management



Marking and pin Assignment

Package Marking and Ordering Information

Device Marking	Device	Device Package	Reel Size	Tape width	Quantity (PCS)
30H50Q	AP30H50Q	PDFN3X3-8L	13 inch	-	5000

ABSOLUTE MAXIMUM RATINGS (T_a=25℃ unless otherwise noted)

Parameter	Symbol	Value	Unit	
Drain-Source Voltage	V _{DS}	30	V	
Gate-Source Voltage	V _{GS}	±20	V	
Continuous Drain Current (T _a =25℃)	ID	40	Α	
Continuous Drain Current (T _a =100℃)	I _D	28	Α	
Pulsed Drain Currenr (1)	I _{DM}	150	Α	
Singel Pulsed Avalanche Energy (2)	Eas	39	mJ	
Power Dissipation	P _D	30	W	
Thermal Resistance from Junction to Case ⁽⁴⁾	Rejc	3.72	°C/W	
Junction Temperature	TJ	150	$^{\circ}$	
Storage Temperature	T _{STG}	-55~ +150	$^{\circ}$ C	



MOSFET ELECTRICAL CHARACTERISTICS(T_a=25℃ unless otherwise noted)

Parameter	Symbol	Test Condition	Min	Туре	Max	Unit			
Static Characteristics									
Drain-source breakdown voltage	V _{(BR)DSS}	V _{GS} = 0V, I _D =250µA	30	-	-	V			
Zero gate voltage drain current	IDSS	V _{DS} =30V, V _{GS} = 0V	-	-	1	μA			
Gate-body leakage current	I _{GSS}	V _{GS} =±20V,V _{DS} = 0V	-	-	±100	nA			
Gate threshold voltage ⁽³⁾	V _{GS(th)}	V _{DS} =V _{GS} , I _D =250μA	1	1.5	2.5	V			
Decis course on maintain (3)	Б	V _{GS} =10V, I _D =15A	-	6.5	9.0	mΩ			
Drain-source on-resistance ⁽³⁾	R _{DS(on)}	V _{GS} =4.5V, I _D =10A	-	9.0	14				
Dynamic characteristics			·						
Input Capacitance	C _{iss}	V _{DS} =15V, V _{GS} =0V, f =1MHz	_	1116	-	pF			
Output Capacitance	Coss		-	187	-				
Reverse Transfer Capacitance	C _{rss}		-	152	-				
Switching characteristics									
Turn-on delay time	t _{d(on)}		-	15	-				
Turn-on rise time	t _r	V _{DD} =15V, I _D =15A,	-	19	-				
Turn-off delay time	t _{d(off)}	V_{GS} =10V, R_{G} =3 Ω	-	35	-	ns			
Turn-off fall time	t _f	-	-	21	-				
Total Gate Charge	Qg	VDS=15V, ID=15A,	-	13.3	-	nC			
Gate-Source Charge	Qgs		-	3.1	-				
Gate-Drain Charge	Qgd	- VGS=10V	-	5	-				
Source-Drain Diode characteristics									
Diode Forward voltage ⁽³⁾	V _{DS}	V _{GS} =0V, I _S =1A	-	-	1.2	V			
Diode Forward current ⁽⁴⁾	ls		-	-	40	Α			

Notes:

- 1. Repetitive Rating: pulse width limited by maximum junction temperature
- 2. EAS Condition: TJ=25 $^{\circ}$ C, VDD=15V, RG=25 $^{\Omega}$, L=0.5mH, IAS=12.6A
- 3. Pulse Test: pulse width≤300µs, duty cycle≤2%
- 4. Surface Mounted on FR4 Board,t≤10 sec



Test Circuit

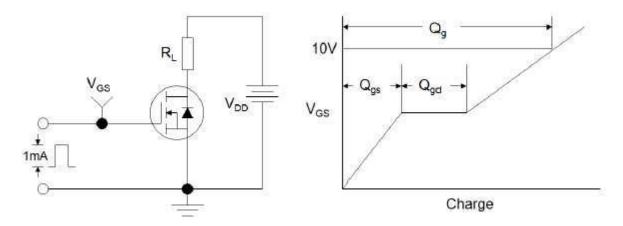


Figure1:Gate Charge Test Circuit & Waveform

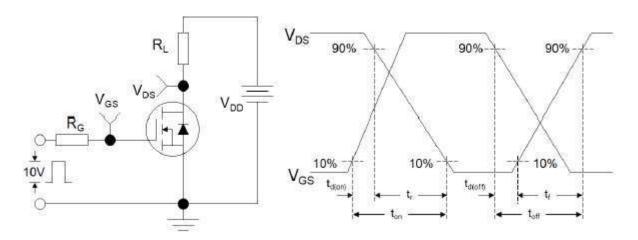


Figure 2: Resistive Switching Test Circuit & Waveforms

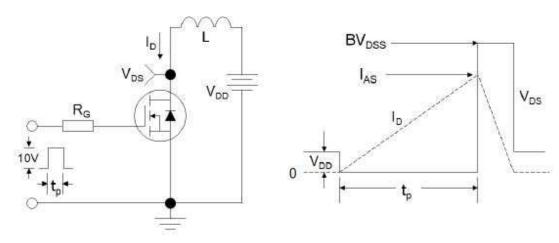


Figure 3:Unclamped Inductive Switching Test Circuit & Waveforms



Typical Performance Characteristics

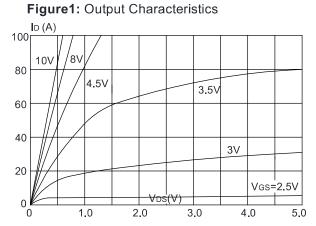


Figure 3:On-resistance vs. Drain Current

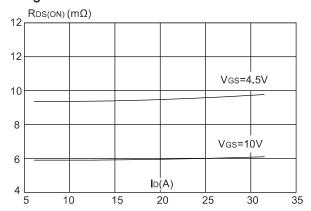


Figure 5: Gate Charge Characteristics

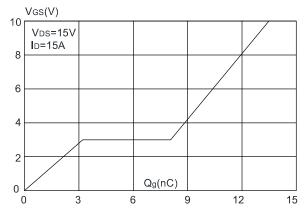


Figure 2: Typical Transfer Characteristics

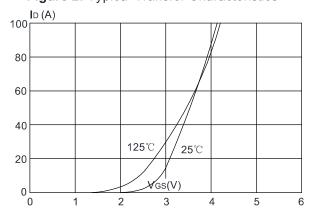


Figure 4: Body Diode Characteristics

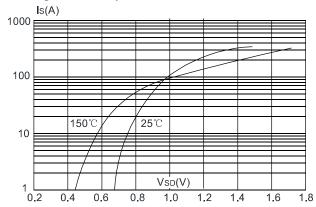
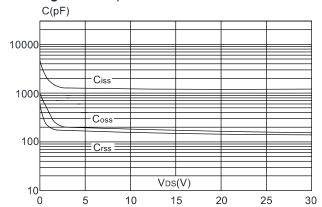


Figure 6: Capacitance Characteristics





DATA SHEET

Figure 7: Normalized Breakdown Voltage vs. Junction Temperature

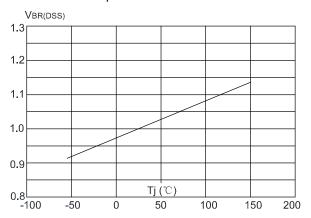


Figure 9: Maximum Safe Operating Area

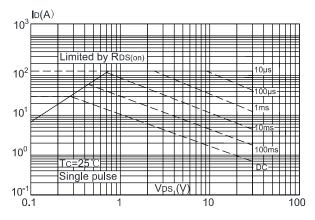


Figure.11: Maximum Effective Transient Thermal Impedance, Junction-to-Case

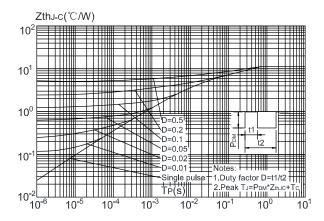


Figure 8: Normalized on Resistance vs. Junction Temperature

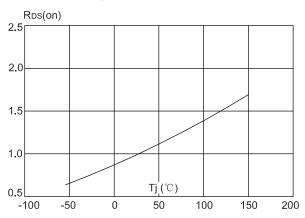
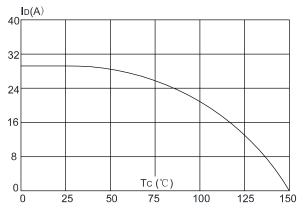


Figure 10: Maximum Continuous Drain Current vs. Case Temperature





PDFN3X3-8L Package Information

